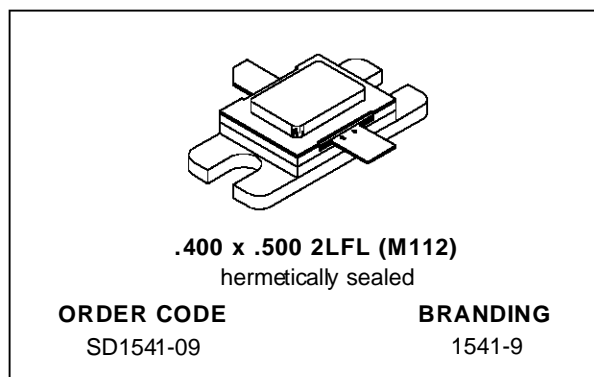
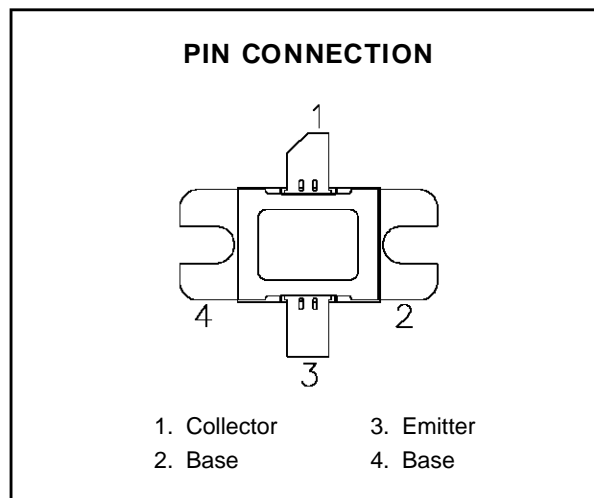


**RF & MICROWAVE TRANSISTORS  
AVIONICS APPLICATIONS**

- DESIGNED FOR HIGH POWER PULSED IFF APPLICATIONS
- 450 WATTS (min.) IFF 1030/1090 MHz
- 7.0 dB MIN. GAIN
- REFRACTORY GOLD METALLIZATION
- BALLASTING AND LOW THERMAL RESISTANCE FOR RELIABILITY AND RUGGEDNESS
- 30:1 LOAD VSWR CAPABILITY AT SPECIFIED OPERATING CONDITIONS
- INPUT MATCHED, COMMON BASE CONFIGURATION


**DESCRIPTION**

The SD1541-09 is a gold metallized silicon NPN planar transistor. The SD1541-09 is designed for applications requiring high peak and low duty cycles such as IFF. The SD1541-09 is packaged in a metal/ceramic package with internal input matching, resulting in improved broadband performance and a low thermal resistance.


**ABSOLUTE MAXIMUM RATINGS** ( $T_{case} = 25^{\circ}C$ )

Symbol	Parameter	Value	Unit
$V_{CBO}$	Collector-Base Voltage	65	V
$V_{CEO}$	Collector-Emitter Voltage	65	V
$V_{EBO}$	Emitter-Base Voltage	3.5	V
$I_C$	Device Current	22	A
$P_{DISS}$	Power Dissipation	1458	W
$T_J$	Junction Temperature	+200	$^{\circ}C$
$T_{STG}$	Storage Temperature	- 65 to +150	$^{\circ}C$

**THERMAL DATA**

$R_{TH(j-c)}$	Junction-Case Thermal Resistance	0.12	$^{\circ}C/W$
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## SD1541-09

### ELECTRICAL SPECIFICATIONS ( $T_{case} = 25^{\circ}C$ )

#### STATIC

Symbol	Test Conditions		Value			Unit
			Min.	Typ.	Max.	
$BV_{CBO}$	$I_C = 25mA$	$I_E = 0mA$	65	—	—	V
$BV_{CES}$	$I_C = 50mA$	$I_B = 0mA$	65	—	—	V
$BV_{EBO}$	$I_E = 10mA$	$I_C = 0mA$	3.5	—	—	V
$I_{CES}$	$V_{CE} = 50V$	$I_E = 0mA$	—	—	25	mA
$h_{FE}$	$V_{CE} = 5V$	$I_C = .25A$	5	—	200	—

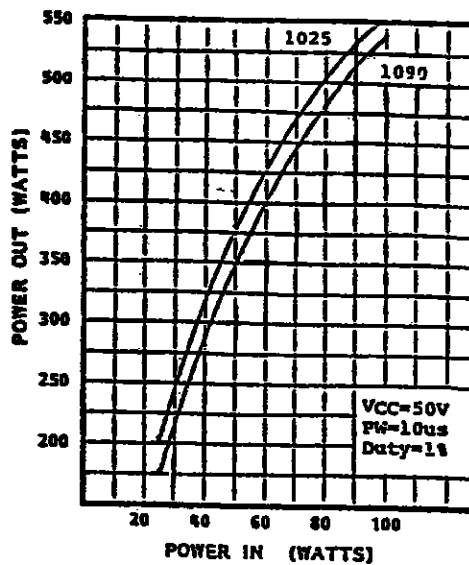
#### DYNAMIC

Symbol	Test Conditions			Value			Unit
				Min.	Typ.	Max.	
$P_{OUT}$	$f = 1090\text{ MHz}$	$P_{IN} = 90\text{ W}$	$V_{CE} = 50\text{ V}$	450	—	—	W
$G_P$	$f = 1090\text{ MHz}$	$P_{IN} = 90\text{ W}$	$V_{CE} = 50\text{ V}$	7.0	—	—	dB

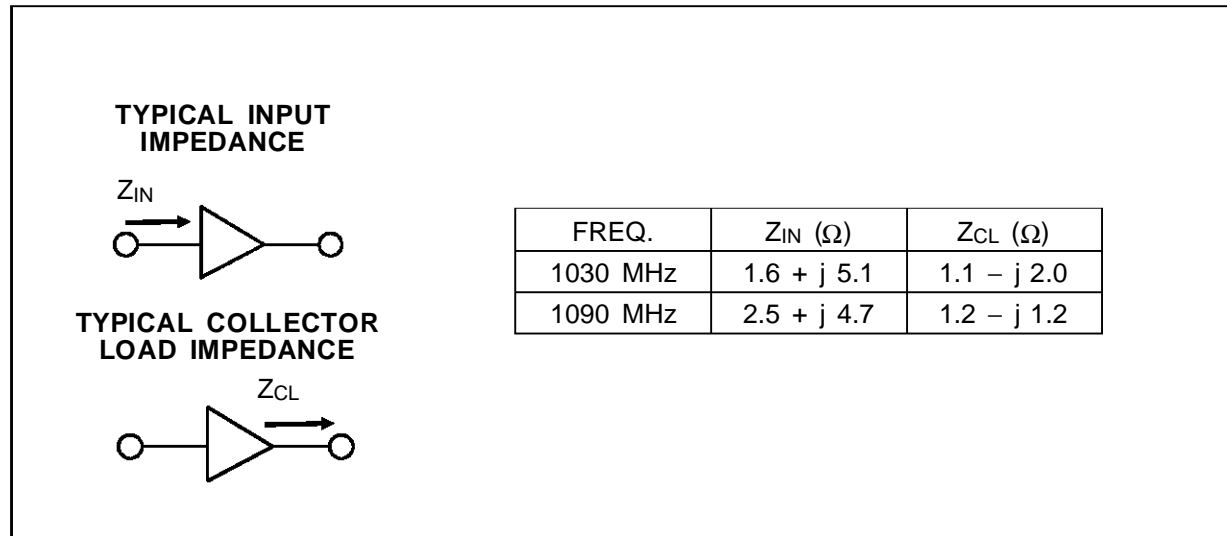
Note: Pulse Width =  $10\mu\text{Sec}$ , Duty Cycle = 1%

### TYPICAL PERFORMANCE

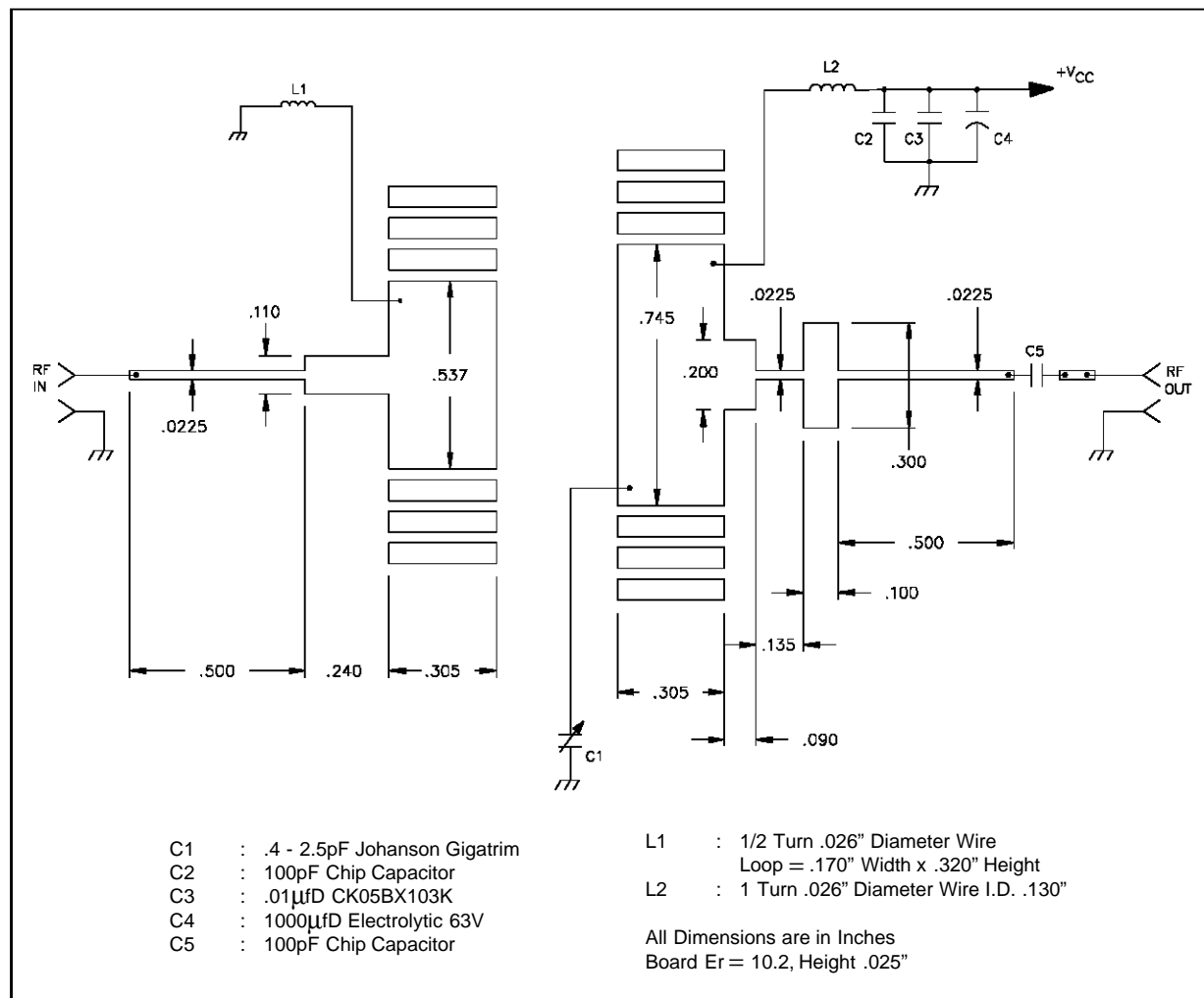
#### POWER OUTPUT vs POWER INPUT



## IMPEDANCE DATA

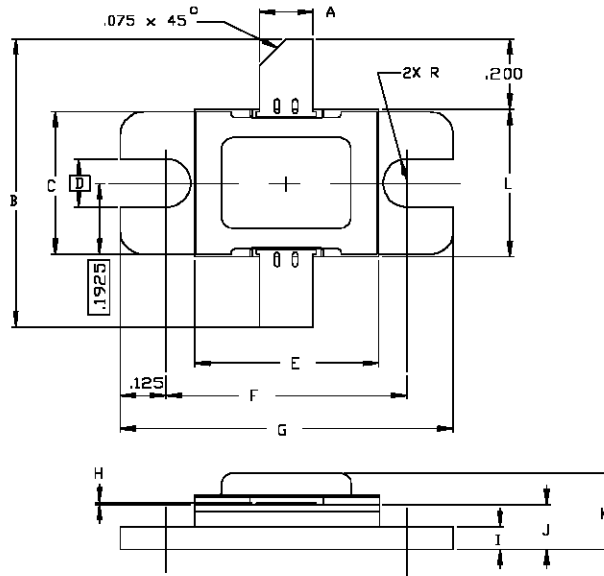


## TEST CIRCUIT LAYOUT



PACKAGE MECHANICAL DATA

Ref.: Dwg. No.12-0112



SGS-THOMSON MICROELECTRONICS		
	MINIMUM Inches/mm	MAXIMUM Inches/mm
A	.145/3,68	.155/3,93
B	.750/19,05	
C	.380/9,65	.390/9,91
D	.130/3,30	
E	.495/12,57	.507/12,88
F	.640/16,26	.655/16,64
G	.890/22,61	.910/23,11
H	.002/0,05	.006/0,15
I	.055/1,40	.065/1,65
J	.115/2,92	.135/3,43
K		.230/5,84
L	.395/10,03	.407/10,34

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